MSKSEMI 美森科













ESD

TVS

TSS

MOV

GDT

PLED

2SC2383-x-MS

Product specification





TRANSISTOR (NPN)

FEATURE

High voltage: VCEO=160V

Large continuous collector current capability

Reference News

SOT-89			MARKING
3	1. 2. 3.	BASE COLLECTOR EMITTER	2383

MAXIMUM RATINGS (T_A =25 $^{\circ}$ C unless otherwise noted)

Symbol	Parameter	Value	Unit
V _{CBO}	Collector-Base Voltage	160	V
VCEO	Collector-Emitter Voltage	160	V
V _{EBO}	Emitter-Base Voltage	6	V
lc	Collector Current -Continuous	1	Α
Pc	Collector Power Dissipation	0.5	W
TJ	Junction Temperature		$^{\circ}$
T _{stg}	Storage Temperature	-55~+150	$^{\circ}$

ELECTRICAL CHARACTERISTICS (Tamb=25°C unless otherwise specified)

Parameter	Symbol	Test conditions	Min	Max	Unit
Collector-base breakdown voltage	V _{(BR)CBO}	lc= 100μA , I _E =0	160		V
Collector-emitter breakdown voltage	V ^{(BR)CEO}	lc= 10mA, I _B =0	160		V
Emitter-base breakdown voltage	V _{(BR)EBO}	l∈= 10μA, lc=0	6		V
Collector cut-off current	Ісво	V _{CB} = 150V, I _E =0		1	μΑ
Emitter cut-off current	I _{EBO}	V _{EB} =6V, I _C =0		1	μA
DC current gain	h _{FE}	V _{CE} =5V, I _C =200mA	100	320	
Collector-emitter saturation voltage	V _{CE(sat)}	lc=500mA, I _B =50mA		1	V
Base-emitter voltage	V _{BE}	lc=5mA, Vc== 5V	0.45	0.75	V
Transition frequency	f ⊤	V _{CE} =5V, I _C =200mA	20		MHz
Collector output capacitance	C _{ob}	V _{CB} = 10V,I _E =0,f=1MHz		20	pF

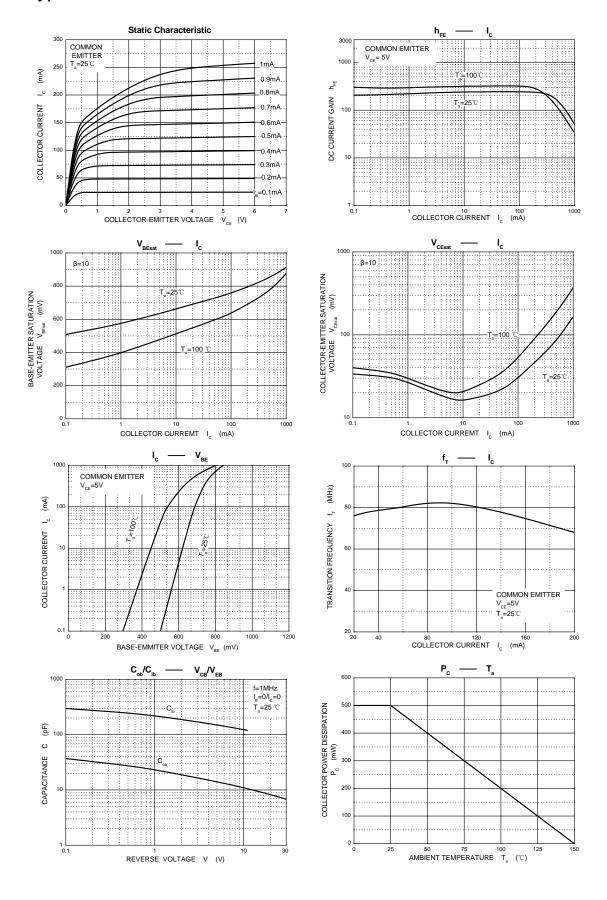
^{*}pulse test

CLASSIFICATION OF hFE

Rank	2SC2383-O-MS	2SC2383-Y-MS	
Range	100-200	160-320	

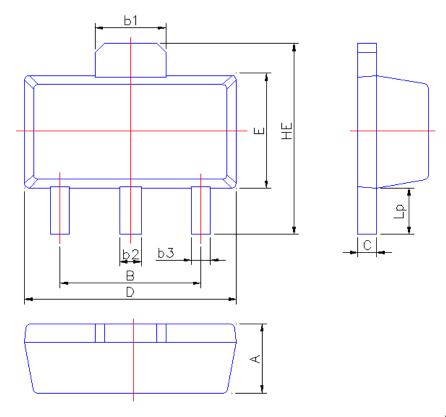


Typical Characteristics





PACKAGE MECHANICAL DATA



SOT-89

	Dimension in Millimeters		
Symbol	Min	Max	
А	1.40	1.60	
В	2.95	3.05	
b1	1.45	1.70	
b2	0.45	0.60	
b3	0.35	0.50	
С	0.35	0.50	
D	4.40	4.60	
E	2.35	2.55	
HE	3.90	4.40	
Lp	0.90	1.10	

REELSPECIFICATION

P/N	PKG	QTY
2SC2383-x-MS	SOT-89	1000



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